This Errata Sheet describes the deviations from the current user documentation. The module oriented classification and numbering system uses an ascending sequence over several derivatives, including already solved deviations. So gaps inside this enumeration can occur.

Current Documentation

• C504 User's Manual 11.97
• C504 Data Sheet May 2000
• Instruction Set Manual 07.2000

Note: Devices marked with EES- or ES are engineering samples which may not be completely tested in all functional and electrical characteristics, therefore they should be used for evaluation only.

Note: * The only difference between AC and AC-T steps is the production line. AC-T is produced by TSMC.

The specific test conditions for EES and ES are documented in a separate Status Sheet.

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1 History List/Change Summary

(since last CPU Step AB, previous Errata Sheet V2.0)

Table 1 Functional Deviations

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<td></td>
<td></td>
</tr>
<tr>
<td>ROM.3</td>
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<td></td>
<td></td>
</tr>
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<td>ROM.4</td>
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<td></td>
<td></td>
</tr>
<tr>
<td>RST.1</td>
<td>Figure in User’s Manual and Data Sheet regarding the Reset Circuitries is incorrect</td>
<td>New</td>
<td></td>
</tr>
<tr>
<td>T2.1</td>
<td>Timer 2 - Concurrent Access on T2CON</td>
<td></td>
<td></td>
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Table 2 AC/DC Deviations

<table>
<thead>
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<th>AC/DC Deviation</th>
<th>Short Description</th>
<th>Fixed in Step</th>
<th>Change</th>
</tr>
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<td>± 4 LSB Total Unadjusted Error (TUE) of A/D Converter</td>
<td></td>
<td></td>
</tr>
<tr>
<td>DC.2</td>
<td>Minimum supply voltage $V_{CC} = 4.75$ V at 40 MHz clock frequency</td>
<td></td>
<td></td>
</tr>
<tr>
<td>DC.3</td>
<td>Maximum value of -70 µA for the logic 0 input current (Ports 1, 2, 3)</td>
<td></td>
<td></td>
</tr>
<tr>
<td>DC.8</td>
<td>Minimum value of -3 µA for the logic 0 input current (Ports 1, 2, 3)</td>
<td></td>
<td></td>
</tr>
<tr>
<td>DC.9</td>
<td>Maximum limit values of the power supply current ($I_{DD}$) for Active Mode</td>
<td></td>
<td></td>
</tr>
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<td>Short Description</td>
<td>Fixed in Step</td>
<td>Change</td>
</tr>
<tr>
<td>------------------</td>
<td>-------------------</td>
<td>---------------</td>
<td>--------</td>
</tr>
<tr>
<td>None.</td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>
2 Functional Deviations

ADC.1: The Continuous Conversion Mode of ADC is not functioning
In the Continuous Conversion Mode, the ADC can not provide the correct digital output value corresponding to the analog input voltage. The device can not start the Continuous Mode.

Workaround:
The Continuous Conversion Mode should only be started by writing ADDATL with dummy data after the ADM bit (ADCON0.3) has been set.
For example:

```
........
........
ORL ADCON0, #00001000b
MOV ADDATL, #11000000b
........
```

CCU.1: Spike at CCx / COUTx pins
A write operation to SFR COINI will cause a spike from low to high level of about 10 ns width (@ 20 MHz external microcontroller clock) at CCx or/and COUTx, if these pins are assigned to the CCU in the following way:

- The CCx or/and COUTx pins are programmed as compare output of the CCU (corresponding bits in SFRs CMSEL0 or CMSEL1 set)
- The COINI register has a “0” in a CCx/COUTx pin related bit position
- The related CCx/COUTx pins are at low level during the write operation to SFR COINI

The occurrence of the spike is independent of the state of compare Timer 1 (running or stopped).

Workaround:
During initialization of the CCU, the spike can be avoided if COINI is written before CMSEL0 or CMSEL1 are written. If the CCU is running, COINI should be never written. If the write operation to COINI is absolutely required. While the CCU is running, an external low pass filter can be used e.g. to suppress the spike at the CCx / COUTx pins.
**ROM.2: ROM Verification Mode 1 is inoperable**

The ROM Verification Mode 1, as described in the C504 User's Manual 06.96 on page 4-8 (or User's Manual 11.97 on page 4-6), is inoperable. This means that it is not possible to verify the internal ROM content using this specific ROM Verification Mode 1.

**Workaround:**

The internal ROM contents of C504-2RM parts are verified during device testing using another verification mode.

**ROM.3: Using MOVC from external ROM to access the internal ROM memory is invalid in unprotected ROM mode.**

In the unprotected ROM Mode, the logic state of /EA pin is only latched in the Reset stage and is not allowed to be changed until performing another Reset. In this case, the MOVC instruction code executed from the external ROM and accessing to the internal ROM code bytes is not possible since /EA pin can not be toggled. With MOVC instructions executed from internal ROM, accessing internal code bytes works as expected.

**Workaround:**

None.

**ROM.4: ROM Verification Mode 2 and verification error signaling at Port 3.5**

For C504-2R ROM version product:

The last block of 16 bytes will always return verification error in the ROM Verification Mode 2.

**Workaround:**

None.
**RST.1: Figure in User’s Manual and Data Sheet regarding the Reset Circuitries is incorrect**

Figure 5-1 in User’s Manual and Figure 6 in Data Sheet show incorrectly that the RESET pin has an internal pullup resistor connected to the VDD. Instead, at the RESET pin, an internal pulldown resistor is connected to the VSS. The correct implementation is illustrated in **Figure 1**.

![Figure 1](image)

**Figure 1 Reset Circuitries**

This correction will be updated to the future versions of the User’s Manual and Data Sheet.

**Workaround:**

Not applicable

**T2.1: Timer 2 - Concurrent Access on T2CON**

A problem might occur when Timer 2 is used together with the functionality of the P1.1/AN1/T2EX pin in the following operating modes:

- Timer 2 as baud rate generator
- Timer 2 in 16-bit capture
- Timer 2 in 16-bit auto-reload with DCEN=0

When a falling edge on P1.1/AN1/T2EX occurs during the execution of a read-modify-write instruction on SFR T2CON, the interrupt flag EXF2 is not set and the related interrupt, if enabled, is not executed.
Workaround:

When using a read-modify-write instruction on T2CON, it must be checked (e.g. by software) whether a high-to-low signal transition occurred at pin P1.1/AN1/T2EX during the execution of the read-modify-write instruction. This can be achieved by polling the level on P1.1/AN1/T2EX before and after the read-modify-write instruction. Timer 2 interrupt has to be disabled during the polling sequence. If a high-to-low signal transition is detected at P1.1/AN1/T2EX, the interrupt EXF2 flag can be set by software.

The following assembly program demonstrates a possible software workaround:

```assembly
workaround:
    clr et2 ; disable t2 interrupt
    jnb p1.1, rmw1 ; normal rmw if pin is already low
rmw2:
    orl t2con, #xxh ; rmw on t2con
    jnb p1.1, force_t2int; force t2int if p1.1 low now
    setb et2 ; enable t2 int again
    sjmp go_on ; go_on, no falling p1.1-edge occurred
force_t2int:
    setb exf2 ; set request flag
    setb et2 ; enable t2 int again, force interrupt exf2
    sjmp go_on ; go_on, falling edge occurred within rmw
rmw1:
    orl t2con, #xxh ; rmw on t2con
    setb et2 ; enable t2 int again & go_on
    sjmp go_on ; go_on

Note: If the external signal on P1.1/AN1/T2EX is a short pulse, the pulse width has to be at least 3 instruction cycles long. Otherwise, the polling sequence of the pin cannot recognize the high-to-low signal transition.
3 Deviations from Electrical- and Timing Specification

**DC.1: ± 4 LSB Total Unadjusted Error (TUE) of A/D Converter**

The total unadjusted error of the A/D Converter does not meet the specified value of the DC characteristics. The value for TUE is limited as follows:

\[ TUE = \pm 4 \text{ LSB} \quad \text{in the } V_{\text{IN}} \text{ range: } V_{\text{SS}} < V_{\text{IN}} < V_{\text{CC}} \]

**Workaround:**

None.

**DC.2: Minimum supply voltage** \( V_{\text{CC}} = 4.75 \text{ V} \) at 40 MHz clock frequency

The minimum rating for supply voltage at 40 MHz clock frequency is \( V_{\text{CC}} = 4.75 \text{ V} \) for all operating temperatures (for C504-L40/C504-2R40 only).

**Workaround:**

None.

**DC.3: Maximum value of - 70 \( \mu \text{A} \) for the logic 0 input current (Ports 1, 2, 3)**

The maximum value of the logic 0 input current for ports 1, 2, and 3 is higher than the specified value:

\[ I_{\text{IL \ max}} = -70 \ \mu \text{A} \quad \text{(instead of } -50 \ \mu \text{A}) \]

**Workaround:**

None.

**DC.8: Minimum value of - 3 \( \mu \text{A} \) for the logic 0 input current (Ports 1, 2, 3)**

The minimum value of the logic 0 input current for ports 1, 2, and 3 is lower than the specified value:

\[ I_{\text{IL \ min}} = -3 \ \mu \text{A} \quad \text{(instead of } -10 \ \mu \text{A}) \]

**Workaround:**

None.
**DC.9: Maximum limit values of the power supply current (I<sub>DD</sub>) for Active Mode**

The maximum limit values of the power supply current (I<sub>DD</sub>) for Active Mode are shown in the table below, instead of the specified values stated in the Data Sheet.

### Power Supply Current

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Symbol</th>
<th>Maximum Limit Values</th>
<th>Unit</th>
</tr>
</thead>
<tbody>
<tr>
<td>Active Mode</td>
<td>C504-2R/ C504-L</td>
<td>24 MHz $I_{DD}$</td>
<td>37.57 mA</td>
</tr>
<tr>
<td></td>
<td></td>
<td>40 MHz $I_{DD}$</td>
<td>60.89 mA</td>
</tr>
</tbody>
</table>

**Workaround:**

None.
4 Application Hints

No application hints for this step.

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